## Notice of References Cited

Application/Control No. 09/616,884	Applicant(s)/Pater Reexamination HO ET AL.	nt Under
Examiner	Art Unit	
Chirag G. Shah	2664	Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,411,611	06-2002	van der Tuijn, Roland	370/337
	В	US-6,741,576	05-2004	Alimi et al.	370/329
	С	US-6,747,968	06-2004	Seppala et al.	370/338
	D	US-6,785,252	08-2004	Zimmerman et al.	370/337
	E	US-6,119,214	09-2000	Dirks, Patrick W. Penzias	711/206
	F	US-6,738,361	05-2004	Immonen et al.	370/328
	G	US-6,597,682	07-2003	Kari, Hannu	370/348
	Н	US-6,115,390	09-2000	Chuah, Mooi Choo	370/443
	1	US-6,034,967	03-2000	Citta et al.	370/443
	J	US-6,765,872	07-2004	Tazaki, Yuji	370/235
	К	US-6,704,321	03-2004	Kamiya, Satoshi	370/412
	L	US-6,563,793	05-2003	Golden et al.	370/236
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	T					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.